

### General Description

- Trench Power MOSFET technology
- Low  $R_{DS(ON)}$
- Low Gate Charge
- High Current Capability
- RoHS and Halogen-Free Compliant

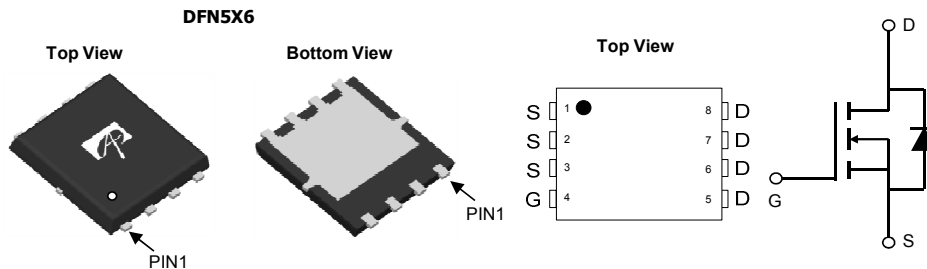
### Applications

- DC/DC Converters in Computing
- Isolated DC/DC Converters in Telecom and Industrial
- See Note I

### Product Summary

|                                  |                  |
|----------------------------------|------------------|
| $V_{DS}$                         | 30V              |
| $I_D$ (at $V_{GS}=10V$ )         | 130A             |
| $R_{DS(ON)}$ (at $V_{GS}=10V$ )  | < 1.85m $\Omega$ |
| $R_{DS(ON)}$ (at $V_{GS}=4.5V$ ) | < 2.5m $\Omega$  |

100% UIS Tested  
 100% Rg Tested



| Orderable Part Number | Package Type | Form        | Minimum Order Quantity |
|-----------------------|--------------|-------------|------------------------|
| AON6312               | DFN 5x6      | Tape & Reel | 3000                   |

### Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

| Parameter                                       | Symbol         | Maximum                 | Units            |
|---|----------------|-------------------------|------------------|
| Drain-Source Voltage                            | $V_{DS}$       | 30                      | V                |
| Gate-Source Voltage                             | $V_{GS}$       | $\pm 20$                | V                |
| Continuous Drain Current                        | $I_D$          | $T_C=25^\circ\text{C}$  | 130              |
|   |                | $T_C=100^\circ\text{C}$ | 83               |
| Pulsed Drain Current <sup>C</sup>               | $I_{DM}$       | 260                     | A                |
| Continuous Drain Current                        | $I_{DSM}$      | $T_A=25^\circ\text{C}$  | 46               |
|   |                | $T_A=70^\circ\text{C}$  | 37               |
| Avalanche Current <sup>C</sup>                  | $I_{AS}$       | 80                      | A                |
| Avalanche energy $L=0.01\text{mH}$ <sup>C</sup> | $E_{AS}$       | 32                      | mJ               |
| $V_{DS}$ Spike                                  | $V_{SPIKE}$    | 36                      | V                |
| Power Dissipation <sup>B</sup>                  | $P_D$          | $T_C=25^\circ\text{C}$  | 50               |
|   |                | $T_C=100^\circ\text{C}$ | 20               |
| Power Dissipation <sup>A</sup>                  | $P_{DSM}$      | $T_A=25^\circ\text{C}$  | 6.2              |
|   |                | $T_A=70^\circ\text{C}$  | 4                |
| Junction and Storage Temperature Range          | $T_J, T_{STG}$ | -55 to 150              | $^\circ\text{C}$ |

### Thermal Characteristics

| Parameter                                  | Symbol          | Typ | Max | Units              |
|--|-----------------|-----|-----|--------------------|
| Maximum Junction-to-Ambient <sup>A</sup>   | $R_{\theta JA}$ | 15  | 20  | $^\circ\text{C/W}$ |
| Maximum Junction-to-Ambient <sup>A,D</sup> |                 |     |     |                    |
| Maximum Junction-to-Case                   | $R_{\theta JC}$ | 1.9 | 2.5 | $^\circ\text{C/W}$ |

Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)

| Symbol                      | Parameter                             | Conditions  | Min | Typ        | Max          | Units         |
|-----------------------------|---------------------------------------|---|-----|------------|--------------|---------------|
| <b>STATIC PARAMETERS</b>    |                                       |   |     |            |              |               |
| $BV_{DSS}$                  | Drain-Source Breakdown Voltage        | $I_D=250\mu\text{A}$ , $V_{GS}=0\text{V}$   | 30  |            |              | V             |
| $I_{DSS}$                   | Zero Gate Voltage Drain Current       | $V_{DS}=30\text{V}$ , $V_{GS}=0\text{V}$<br>$T_J=55^\circ\text{C}$                  |     |            | 1<br>5       | $\mu\text{A}$ |
| $I_{GSS}$                   | Gate-Body leakage current             | $V_{DS}=0\text{V}$ , $V_{GS}=\pm 20\text{V}$  |     |            | $\pm 100$    | nA            |
| $V_{GS(th)}$                | Gate Threshold Voltage                | $V_{DS}=V_{GS}$ , $I_D=250\mu\text{A}$  | 1.3 | 1.75       | 2.2          | V             |
| $R_{DS(on)}$                | Static Drain-Source On-Resistance     | $V_{GS}=10\text{V}$ , $I_D=20\text{A}$<br>$T_J=125^\circ\text{C}$                   |     | 1.5<br>2.0 | 1.85<br>2.45 | m $\Omega$    |
|                             |                                       | $V_{GS}=4.5\text{V}$ , $I_D=20\text{A}$   |     | 2.0        | 2.5          |               |
| $g_{FS}$                    | Forward Transconductance              | $V_{DS}=5\text{V}$ , $I_D=20\text{A}$   |     | 125        |              | S             |
| $V_{SD}$                    | Diode Forward Voltage                 | $I_S=1\text{A}$ , $V_{GS}=0\text{V}$  |     | 0.68       | 1            | V             |
| $I_S$                       | Maximum Body-Diode Continuous Current |   |     |            | 60           | A             |
| <b>DYNAMIC PARAMETERS</b>   |                                       |   |     |            |              |               |
| $C_{iss}$                   | Input Capacitance                     | $V_{GS}=0\text{V}$ , $V_{DS}=15\text{V}$ , $f=1\text{MHz}$                          |     | 3100       |              | pF            |
| $C_{oss}$                   | Output Capacitance                    |   |     | 875        |              | pF            |
| $C_{riss}$                  | Reverse Transfer Capacitance          |   |     | 105        |              | pF            |
| $R_g$                       | Gate resistance                       | $f=1\text{MHz}$   | 1.1 | 2.3        | 3.5          | $\Omega$      |
| <b>SWITCHING PARAMETERS</b> |                                       |   |     |            |              |               |
| $Q_g(10\text{V})$           | Total Gate Charge                     | $V_{GS}=10\text{V}$ , $V_{DS}=15\text{V}$ , $I_D=20\text{A}$                        |     | 43         | 65           | nC            |
| $Q_g(4.5\text{V})$          | Total Gate Charge                     |   |     | 20         | 30           | nC            |
| $Q_{gs}$                    | Gate Source Charge                    |   |     | 8.5        |              | nC            |
| $Q_{gd}$                    | Gate Drain Charge                     |   |     | 6          |              | nC            |
| $t_{D(on)}$                 | Turn-On DelayTime                     | $V_{GS}=10\text{V}$ , $V_{DS}=15\text{V}$ , $R_L=0.75\Omega$ ,<br>$R_{GEN}=3\Omega$ |     | 11.5       |              | ns            |
| $t_r$                       | Turn-On Rise Time                     |   |     | 5          |              | ns            |
| $t_{D(off)}$                | Turn-Off DelayTime                    |   |     | 40         |              | ns            |
| $t_f$                       | Turn-Off Fall Time                    |   |     | 8          |              | ns            |
| $t_{rr}$                    | Body Diode Reverse Recovery Time      | $I_F=20\text{A}$ , $di/dt=500\text{A}/\mu\text{s}$                                  |     | 17         |              | ns            |
| $Q_{rr}$                    | Body Diode Reverse Recovery Charge    | $I_F=20\text{A}$ , $di/dt=500\text{A}/\mu\text{s}$                                  |     | 36         |              | nC            |

A. The value of  $R_{\theta JA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The Power dissipation  $P_{DSM}$  is based on  $R_{\theta JA} t \leq 10\text{s}$  and the maximum allowed junction temperature of  $150^\circ\text{C}$ . The value in any given application depends on the user's specific board design.

B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}=150^\circ\text{C}$ , using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature  $T_{J(MAX)}=150^\circ\text{C}$ .

D. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to case  $R_{\theta JC}$  and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using  $<300\mu\text{s}$  pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(MAX)}=150^\circ\text{C}$ . The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ .

I. For application requiring slow  $>1\text{ms}$  turn-on/turn-off, please consult AOS FAE for proper product selection.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

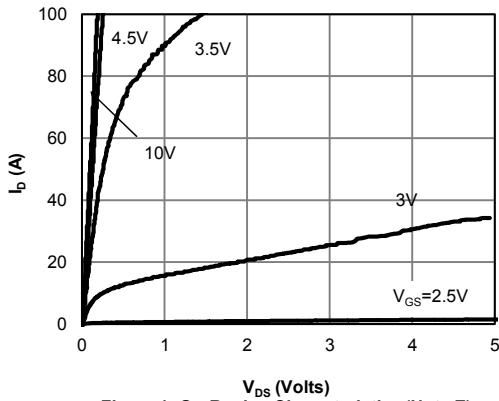


Figure 1: On-Region Characteristics (Note E)

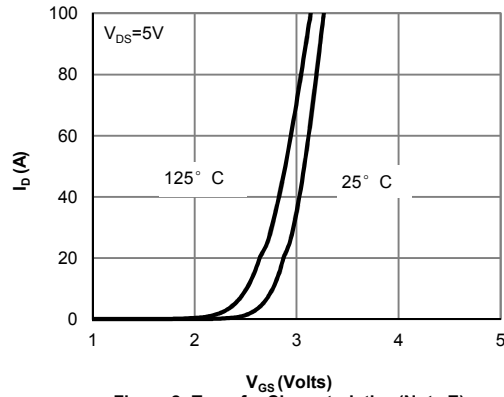


Figure 2: Transfer Characteristics (Note E)

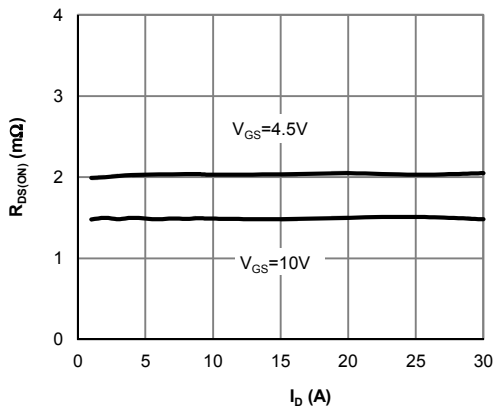


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

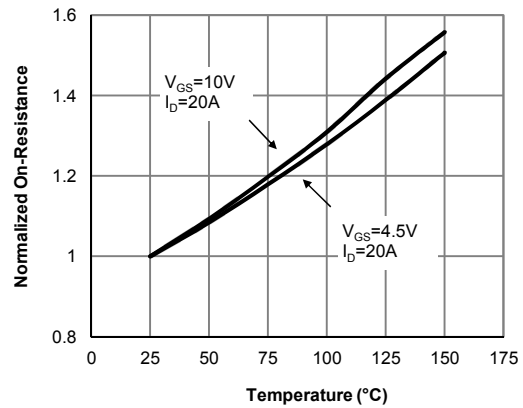


Figure 4: On-Resistance vs. Junction Temperature (Note E)

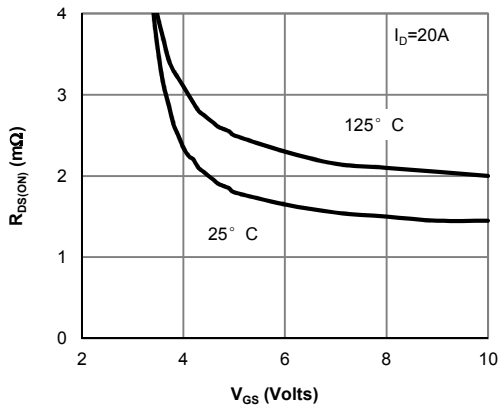


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

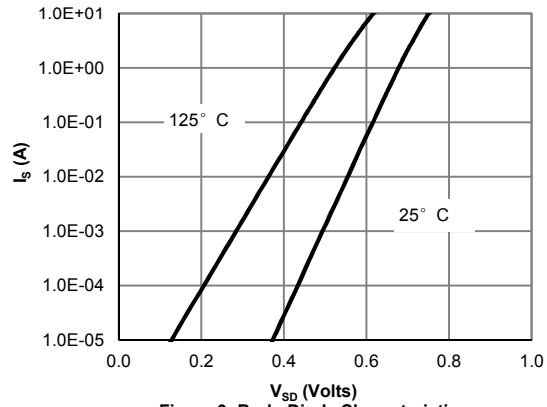


Figure 6: Body-Diode Characteristics (Note E)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

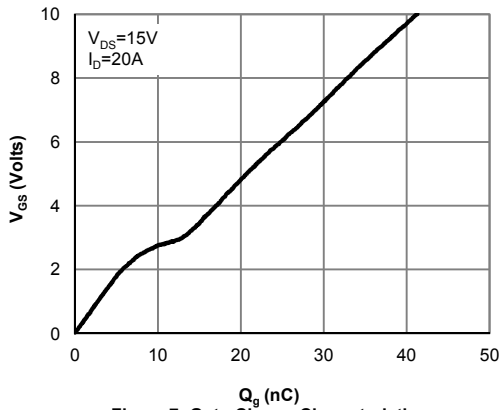


Figure 7: Gate-Charge Characteristics

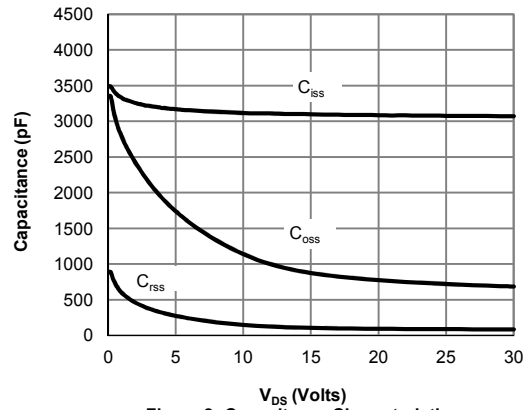


Figure 8: Capacitance Characteristics

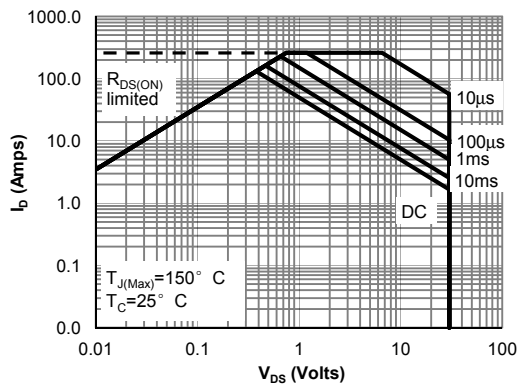


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

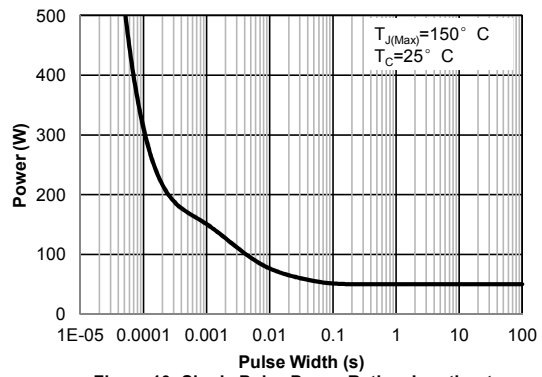


Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)

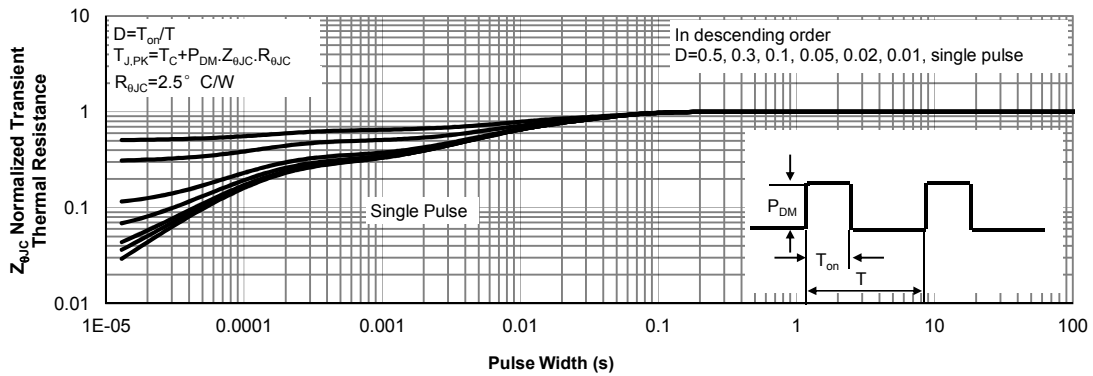


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

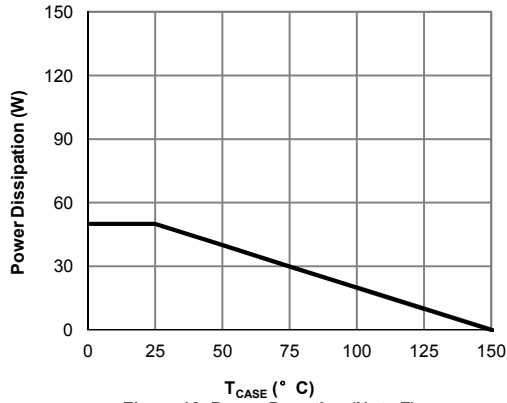


Figure 12: Power De-rating (Note F)

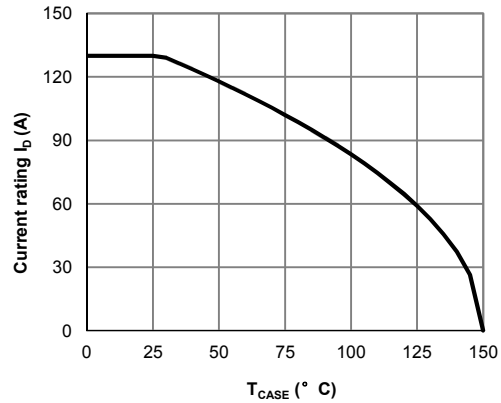


Figure 13: Current De-rating (Note F)

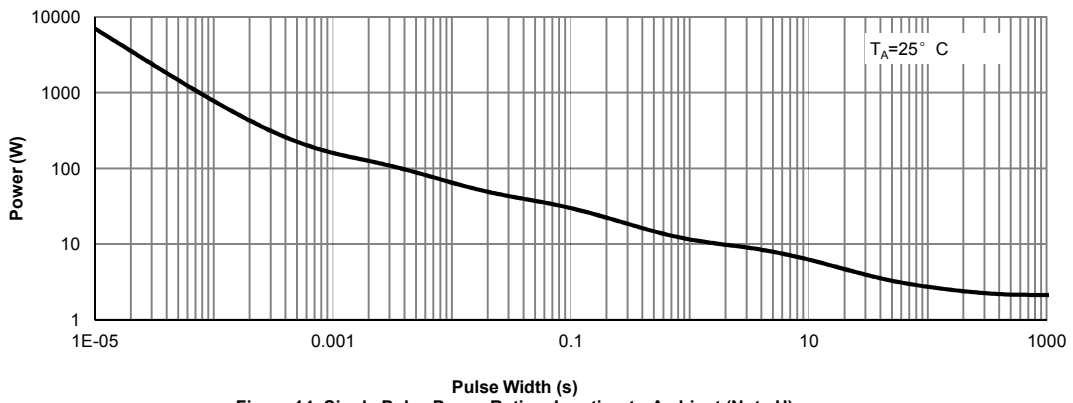


Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note H)

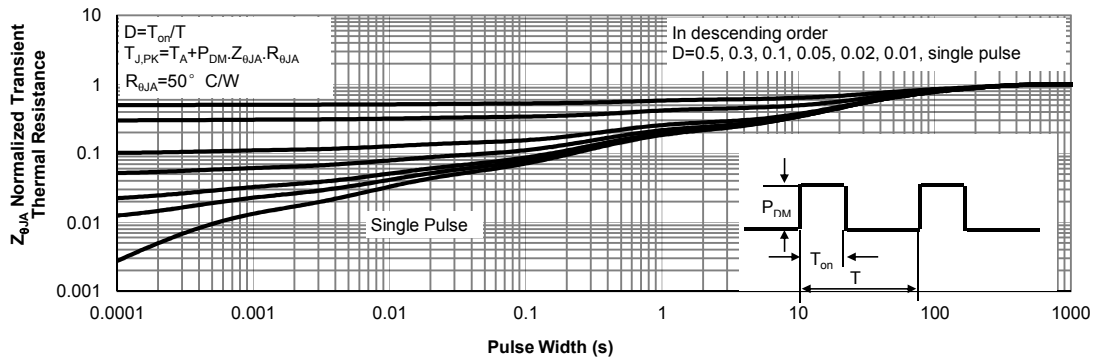


Figure 15: Normalized Maximum Transient Thermal Impedance (Note H)

Figure A: Gate Charge Test Circuit & Waveforms

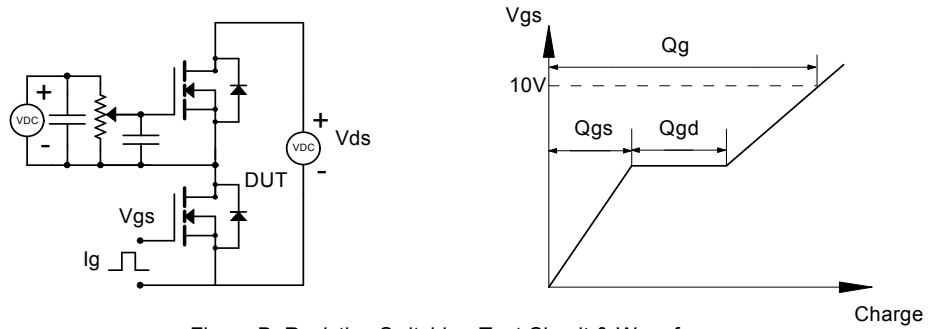


Figure B: Resistive Switching Test Circuit & Waveforms

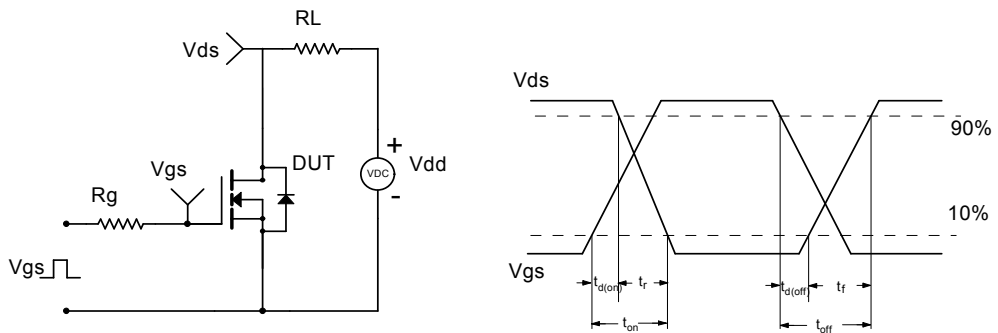


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

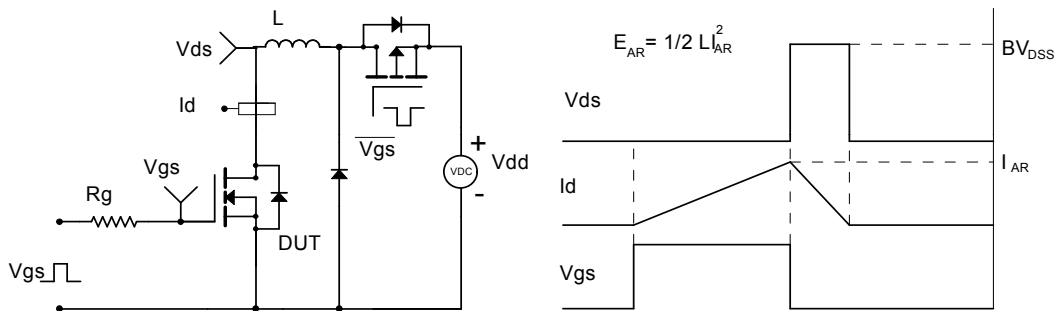
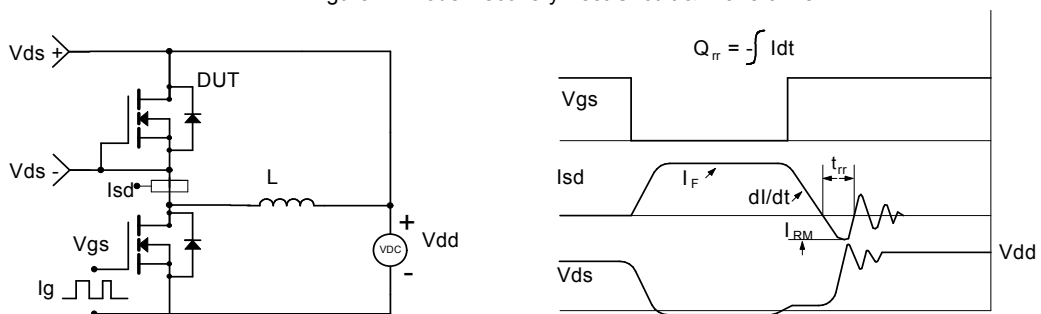


Figure D: Diode Recovery Test Circuit & Waveforms



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